

Agilent E8267C PSG Vector Signal Generators

Data Sheet



All specifications and characteristics apply over a 0 to 55°C range (unless otherwise stated) and apply after a 45 minute warm-up time. Supplemental characteristics, denoted as typical or nominal, provide additional (non-warranted) information.

PSG Signal Generators

	Option 520	Option 540
	250 kHz to 20 GHz	250 kHz to 40 GHz
CW only	E8247C	E8247C
Analog	E8257C	E8257C
Vector	E8267C	

(See E8247C/E8257C data sheet for PSG CW and Analog Signal Generator specifications)

Definitions

Specifications (spec): represent warranted performance.

Typical (typ): performance is not warranted. It applies at 25°C. 80% of all products meet typical performance.

Nominal (nom): values are not warranted. They represent the value of a parameter that is most likely to occur; the expected or mean value. They are included to facilitate the application of the product.

Standard (std): No options are included when referring to the signal generator unless noted otherwise.



E8267C PSG Vector Signal Generator

Choose your required frequency range as an option when configuring your PSG series. Please refer to the related literature in the section PSG application and product information for additional information.

Agilent microwave vector signal generators options

Frequency range	(required option)			
Option 520	250 kHz to 20 GHz			
Enhanced phase n	oise			
Option UNR	Enhanced phase noise performance			
Narrow pulse mod	dulation			
Option 1E6	Provides narrow pulse modulation below 3.2 GHz			
Analog (ramp) sw	/eep			
Option 007	Provides analog (ramp) sweep and scalar network analyzer interface			
Connectors				
Option 1ED	Type-N (f) connector			
Option 1EM	Moves all connector to rear panel			
Power supply				
Option UNS	External module allows operation at 400 Hz			
Internal baseband	generator with memory			
Option 002	Internal baseband generator with 32 Msample memory			
Option 005	6 GB internal hard drive			
Wideband externa	al I/Q			
Option 015	Wideband external I/Q inputs			

Specifications

Frequency

Range ¹				
Option 520	250 kHz to 20 GHz ²			
Resolution				
CW	0.001 Hz			
All Sweep Modes	0.01 Hz			
Accuracy	Aging rate ± temperature effects± line voltage effects			
Switching speed ³	< 15 ms (typical)			
Phase offset	Adjustable in nominal 0.1	° increments.		
Frequency bands				
Band	Frequency range	N #		
	1 250 kHz to 25	i0 MHz 1/8		
	2 > 250 to 500	MHz 1/16		
	3 > 500 MHz to	o 1 GHz 1/8		
	4 > 1 to 2 GHz	1/4		
	5 > 2 to 3.2 GH	z 1/2		
	6 > 3.2 to 10 G	Hz 1		
	7 > 10 to 20 GHz 2			
Internal timebase reference oscilla	ator			
	Standard	Option UNR		
Aging rate	$< \pm 1 \times 10^{-7}$ /year or	< ±3 x10 ⁻⁸ /year or		
	< ±4.5 x 10 ^{.9} /day	< ±2.5 x 10 ⁻¹⁰ /day		
	after 45 days	after 30 days		
Temperature effects (typical)	< ±5 x 10 ⁻⁸ 0 to 55°C	< ±4.5 x 10 ^{.9} 0 to 55°C		
Line voltage effects (typical)	$< \pm 2 \times 10^{-9}$ for	< ±2 x 10 ⁻¹⁰ for		
	+5% –10% change	±10% change		
External reference frequency	1, 2, 2.5, 5, 10 MHz	10 MHz only		
	(within 1 ppm) (within 1 ppm)			
Reference output				
Frequency	10 MHz			
Amplitude	$>$ +4 dBm into 50 Ω loa	d (typical)		
External reference input				
Amplitude	> -3 dBm			
Opt UNR	$5 \text{ dBm} \pm 5 \text{ dB}^4$			
Input impedance	50 $oldsymbol{\Omega}$ (nominal)			

Useable to 100 kHz
In ramp sweep mode (Option 007), resolution is limited with narrow spans and slow sweep speeds. Refer to ramp sweep specifications for more information.
To within 0.1 ppm of final frequency above 250 MHz or within 100 Hz below 250 MHz
To optimize phase noise 5 dBm ± 2 dB

Digital sweep

Operating modes

Ramp (analog) sweep (Option 007)¹

4

		nequency of amplitud			
Sweep range		. , .			
Frequency sweep	Within instrument frequency range				
Amplitude sweep	Within attenua	Within attenuator hold range			
Dwell time	1 ms to 60 s	-			
Frequency settling time	28 ms (typical)			
Amplitude settling time	10 ms (typical)			
Number of points	2 to 1601	·			
Triggering	Auto, external	, single, or GPIB			
Operating modes	Synthesized fr	equency sweep			
	(start/stop), (c	enter/span), (swept C	CW)		
	Power (amplit	ude) sweep (start/sto	p)		
	Manual sweep	0			
	RPG control be	etween start and stop	frequencies		
	Alternate swe	ер			
	Alternates suc	cessive sweeps betwe	en current and stored states		
Sweep span range	Settable from	minimum ² to full rang	е		
Maximum sweep rate	Start frequency	Maximum swee	o rate Max span for		
			100ms sweep		
	250 kHz to <0.5 GHz	25 MHz/ms	2.5 GHz		
	0.5 to <1 GHz	50 MHz/ms	5 GHz		
	1 to <2 GHz	100 MHz/ms	10 GHz		
	2 to <3.2 GHz	200 MHz/ms	20 GHz		
	≥3.2 GHz	400 MHz/ms	20 GHz		
Frequency accuracy		\pm 0.05% of span \pm timebase (at 100 ms sweep time, for			
		sweep spans less than maximum values given above)			
			s sweep time increases ³		
Sweep time	(forward swee	(forward sweep, not including bandswitch and retrace intervals)			
Resolution	1 ms				
Manual mode		Settable 10 ms to 99 seconds			
Auto mode	Set to minimu	Set to minimum value determined by maximum sweep rate			
	and 8757D se				
Triggering		Auto, external, single, or GPIB			
Markers		nt continuously variab			
Display		y or RF amplitude puls			
Functions		M1 to center, M1/M2 to start/stop, marker delta			
Two-tone (master/slav	ve)				
measurements ⁴		Two PSG's can synchronously track each other, with			
	independent c	independent control of start/stop frequencies			
Network analyzer comp	atibility Fully compatib	le with Agilent 8757D	scalar network analyzer ⁵		
	Also useable v	Also useable with Agilent 8757A/C/E scalar network analyzers			
	for making bas	for making basic swept measurements. ⁶			
	6	•			

Step sweep of frequency or amplitude or both (start to stop) List sweep of frequency or amplitude or both (arbitrary list)

 GPIB system interface is not supported with 8757A/C/E, only with 8757D. As a result, some features of 8757A/C/E, such as frequency display, pass-through mode, and alternate sweep, do not function with PSG signal generators.

^{1.} During Ramp sweep operation, AM and Pulse Modulation are useable but not specified; FM, Phase Modulation, Wideband AM and I/Q modulation are not useable.

Minimum settable sweep span is proportional to carrier frequency and sweep time. Actual sweep span may be slightly different than desired setting for spans less than [0.00004% of carrier frequency or 140 Hz] x [sweep time in seconds]. Actual span will always be displayed correctly.

Typical accuracy for sweep times > 100 ms can be calculated from the equation: [(0.005% of span) + (sweep time in seconds)] ± timebase. Accuracy is not specified for sweep times < 100 ms.

^{4.} For Master/Slave operation use Agilent Technologies part #8120-8806 Master/Slave interface cable.

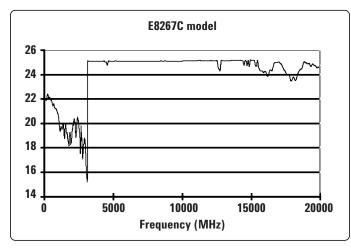
^{5.} When measuring low-pass devices in AC mode, dynamic range may be reduced up to 10dB below 3.2 GHz

Output

Power¹ (dBm)

Frequency range	
250 kHz to 3.2 GHz ²	-130 to +13
250 kHz to 3.2 GHz (with Option 1E6) ²	-130 to +10
> 3.2 to 20 GHz ³	-130 to +18
Step attenuator	0 to 115 dB in 5 dB steps

Measured maximum available power in CW mode



Attenuator hold range Minimum			(Same as max power sweep range) From –15 dBm to maximum specified output power with step attenuator in 0–dB position.			
			Can be offse	t using step atten	uator.	
Amplitude swit	ching speed	14				
CW or analog mo	dulation		< 5 ms (typic	cal)		
When using powe	sing power search < 25 ms (typical)					
Level accuracy	⁵ (dB)					
Frequency	> +10 dBm	+10 to –10 dBm	–10 to –70 dBm	–70 to –90 dBm	–90 to –110 dBm	
250 kHz to 2 GHz	±0.6	±0.6	±0.7	±0.8	±1.4	
> 2 to 20 GHz	±0.8	±0.8	±0.9	±1.0	±1.7	
CW Level accu	racy with I/	Q modulation	(With PRBS	(With PRBS modulated data)		
(relative to CW) ⁶						
With ALC On:						
OAM or OPSK formats ⁷		± 0.2 dB				
		± 0.2 dB				
Constant-amplitude formats (FSK, GMSK, etc) With ALC Off: ⁸		± 0.2 uD				

1. Maximum power specification is warranted from 15 to 35° C, and is typical from 0 to 15° C. Maximum power over the 35 to 55°C range typically degrades less than 2 dB

2. With I/Q modulation on, maximum power specification is typical. With external inputs enabled,

 $\sqrt{(l^2 + Q^2)} > 0.2 V_{rms}$. <u>With I/Q</u> modulation on, maximum power specification is typically +15 dBm. With external inputs enabled, 3. $\sqrt{(l^2 + Q^2)} > 0.2 V_{rms}$. To within 0.1 dB of final amplitude within one attenuator range

4.

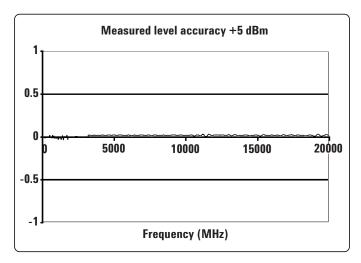
Specifications apply in CW and list/step sweep modes over the 15 to 35° C temperature range, with 5. attenuator hold off (normal operating mode). Degradation outside this range, for ALC power levels > -5 dBm, is typically < 0.3 dB. In Ramp sweep mode (with Option 007), specifications are typical. For instruments with Type-N connectors (Option 1ED), specifications are degraded typically 0.2 dB above 18 GHz. Level accuracy is not specified below -110 dBm.

6. If external inputs are used, specification applies with input level $\sqrt{(I^2 + Q^2)} = 0.3 V_{rms}$ and I/Q modulator attenuation = 10 dB.

Measured with symbol rate > 10 kHz and power \leq 0 dBm. 7.

8. Relative to ALC on, after power search is executed. When applying external I/Q signals with ALC off, output level will vary directly with I/Q input level.

20 GHz level accuracy



Resolution	0.01 dB	
Temperature stability	0.01 dB/°C (typical)	
User flatness correction		
Number of points	2 to 1601 points/table	
Number of tables	Up to 10,000, memory limited	
Path loss	Arbitrary, within attenuator range	
Entry modes	Remote power meter ¹ , remote bus, manual	
	(user edit/view)	
Output impedance	50 Ω (nominal)	
SWR (internally leveled, typical)		
250 kHz to 2 GHz	< 1.4:1	
> 2 GHz to 20 GHz	< 1.6:1	
Leveling modes	Internal leveling, external detector leveling, millimeter source module, ALC Off	
External detector leveling		
Range -0.2 mV to -0.5 V, (nominal) (-36 dBm to using Agilent 33330D/E detector)		
Bandwidth	10 kHz (typical)	
	(Note: not intended for pulsed operation)	
Maximum reverse power	1/2 Watt (nominal)	

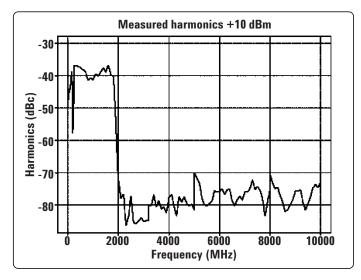
^{1.} Compatible with Agilent Technologies EPM Series (E4418B and E4419B) power meters.

Spectral purity

3/Harmonics¹

- < 1 MHz 1 MHz to 2 GHz
- > 2 GHz to 20 GHz
- (dBc at +10 dBm or maximum specified output power, whichever is lower) -27 dBc (typical) -27 dBc -55 dBc

20 GHz Measured harmonics



Sub-harmonics: ²	(dBc at +10 dBn	(dBc at +10 dBm or maximum specified output power,		
	whichever is low	whichever is lower)		
250 kHz to 10 GHz	None			
> 10 GHz to 20 GHz	<-60 dBc			
Non-harmonics:	,	n or maximum specified output power, er, for offsets > 3 KHz [>300 Hz with		
Frequency	Spec	Typical		
250 kHz to 250 MHz	-65	-72 for > 10 kHz offsets		
> 250 MHz to 1 GHz	-80			
> 1 to 2 GHz	-74	82		
> 2 to 3.2 GHz	68	-76		
> 3.2 to 10 GHz	-62	-70		
> 10 to 20 GHz	-56	64		
SSB phase noise (CW)	Offset from carrie	er (dBc/Hz)		
Frequency	20 kHz	20 kHz (typical)		
250 kHz to 250 MHz	-130	-134		
> 250 to 500 MHz	-136	-140		
> 500 MHz to 1 GHz	-130	-134		
> 1 to 2 GHz	-124	-128		
> 2 to 3.2 GHz	-120	-124		
> 3.2 to 10 GHz	-110	-113		
> 10 to 20 GHz	-104	-108		

1. Specifications for harmonics beyond maximum instrument frequencies are typical.

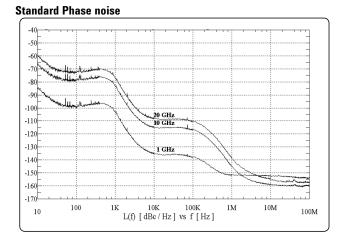
2. 3. Specifications for sub-harmonics beyond maximum instrument frequencies are typical.

Performance is typical for spurs at frequencies above the maximum operating frequency of the instrument. Specifications apply for CW mode only. Performance typically is –60 dBc between 200 and 250 MHz.

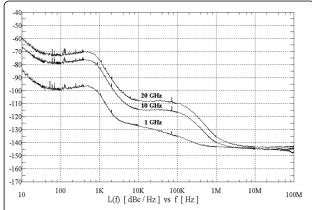
Option UNR: Enhanced SSB phase noise (CW)

	Offset from ca	rrıer (dBc/Hz)		
Frequency	100 Hz	1 kHz	10 kHz	100 kHz
	spec (typical)	spec (typical)	spec (typical)	spec (typical)
250 kHz to 250 MHz	-94 (-115)	-110 (-123)	-128 (-132)	–130 (–133)
> 250 to 500 MHz	-100 (-110)	-124 (-130)	-132 (-136)	–136 (–141)
> 500 MHz to 1 GHz	-94 (-104)	—118 (—126)	-130 (-135)	-130 (-135)
> 1 to 2 GHz	-88 (-98)	—112 (—120)	-124 (-129)	-124 (-129)
> 2 to 3.2 GHz	-84 (-94)	-108 (-116)	-120 (-125)	-120 (-125)
> 3.2 to 10 GHz	-74 (-84)	-98 (-106)	—110 (—115)	—110 (—115)
> 10 to 20 GHz	-68 (-78)	-92 (-100)	-104 (-107)	-104 (-109)
Residual FM				
CW mode		< N x 8 Hz (typi	ical)	
Option UNR		< N x 4 Hz (typi	ical)	
Ramp sweep mode:		< N x 1 kHz (typ	pical)	
(rms, 50 Hz to 15 kHz	bandwidth)			
Broadband noise		(CW mode at +10 dBm output, for offsets > 10 MHz)		
> 2.4 to 20 GHz		<-148 dBc/Hz	(typical)	

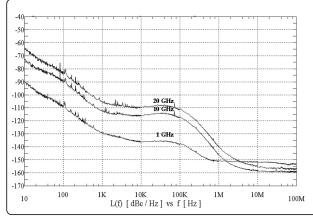
Measured phase noise with E5500 and plotted without spurs



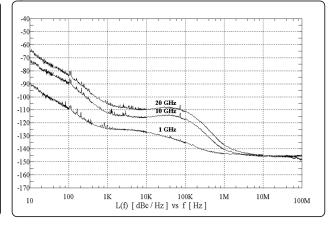
Standard phase noise performance with I/Q modulation on¹







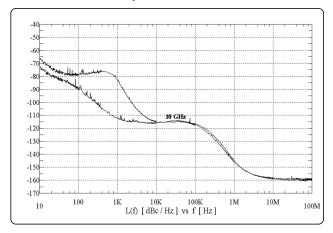


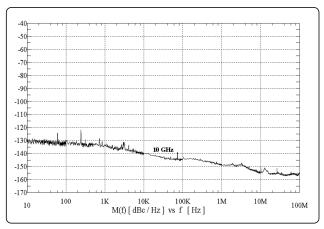


1. External I/Q input level $\sqrt{(l^2 + Q^2)} = 250 \text{ mV}_{rms}$, I/Q modulator attenuator set to auto.

Measured standard vs. Option UNR at 10 GHz

Measured AM noise at 10 GHz





Typical RMS jitter:¹

Standard

Carrier	SONET/SDH	RMS jitter	Unit intervals	Time	
frequency	data rates	bandwidth	(µUI)	(fs)	
155 MHz	155 MB/s	100 Hz to 1.5 MHz	95	497	
622 MHz	622 MB/s	1 kHz to 5 MHz	54	55	
2.488 GHz	2488 MB/s	5 kHz to 15 MHz	64	24	
9.953 GHz	9953 MB/s	20 kHz to 80 MHz	162	16	
ption UNR					
Carrier	SONET/SDH	RMS jitter	Unit intervals	Time	
frequency	data rates	bandwidth	(μUI)	(fs)	
155 MHz	155 MB/s	100 Hz to 1.5 MHz	85	400	
622 MHz	622 MB/s	1 kHz to 5 MHz	25	39	
2.488 GHz	2488 MB/s	5 kHz to 15 MHz	61	24	
9.953 GHz	9953 MB/s	20 kHz to 80 MHz	158	15	

Calculated from phase noise performance in CW mode only at +3 dBm. For other frequencies, data rate, or bandwidths, please contact your sales representative.

Frequency modulation

Maximum deviation	N x 8 MHz		
Resolution	0.1% of deviation or 1 Hz, whichever is greater		
Deviation accuracy	< ± 3.5%	of FM deviation + 20 Hz	
	(1 kHz rat	e, deviations < N x 800 kHz)	
Modulation frequency	response		
Path	Rates (at 100 kHz deviation	n)	
	1 dB Bandwidth	3 dB Bandwidth (typical)	
FM 1	dc/20 Hz to 100 kHz	dc/5 Hz to 10 MHz	
FM 2	dc/20 Hz to 100 kHz	dc/5 Hz to 1 MHz	
dc FM ¹ carrier offset	$\pm 0.1\%$ of set deviation + (N x 8 Hz)		
Distortion	< 1% (1 kHz rate, deviations < N x 800 kHz)		
Sensitivity	±1 V _{peak} for indicated deviation		
Paths			
	modulatio	n. Either path may be switched to any one of	
	the modul	ation sources: Ext1, Ext2, internal1, internal2.	
	The FM2	path is limited to a maximum rate of 1 MHz.	
	The FM2	path must be set to a deviation less than FM1.	

Phase modulation

Maximum deviation		N x 80 rad	ians
	(N x 8 radians in high-bandwidth mode)		
Resolution	0.1% of set deviation		
Deviation accuracy	viation accuracy $< \pm 5\%$ of deviation + 0.01 radians		deviation + 0.01 radians
		(1 kHz rate	, normal BW mode)
Modulation frequency	response		
Mode	Maximum D	eviation	Rates (3 dB BW)
Normal BW	N x 80 rad		dc – 100 kHz
High BW	N x 8 rad		dc – 1 MHz (typical)
Distortion		< 1 % (1 k	Hz rate, THD, dev < N x 80 rad,
		normal BW mode)	
Sensitivity		±1 V _{peak} fo	or indicated deviation
Paths		Φ M1 and	Φ M2 are summed internally for composite
		modulation	. Either path may be switched to any one of
		the modula	tion sources: Ext1, Ext2, internal1, internal2.
		The Φ M2 p	both must be set to a deviation less than Φ M1.

Amplitude modulation

(f_c > 2 MHz)² (typical)

Depth	n Linear mode		Exponential (log) mode
			(Downward modulation only)
Maximum	> 90%		> 20 dB
Settable ³	0 to 100 %		0 to 40 dB
Resolution	0.1%		0.01 dB
Accuracy (1 kHz rate)	< ±(6 % of s	etting + 1 %)	$< \pm (2\% \text{ of setting} + 0.2 \text{ dB})$
Ext sensitivity	±1 V _{peak} for		-1 V for indicated depth
	indicated dep	oth	
Rates (3 dB bandwidth,	30% depth)	dc/10 Hz to	100 kHz (typical) (useable to 1 MHz)
Distortion (1 kHz rate, I	linear mode, THD)	
30% AM		< 1.5%	
90% AM		< 4 %	
Paths		modulation.	A2 are summed internally for composite Either path may be switched to any one of on sources: Ext1, Ext2, internal1, internal2.

 $\hline 1. \quad \mbox{At the calibrated deviation and carrier frequency, within 5°C of ambient temperature at time of user calibration.} \\ 2. \quad \mbox{For } f_c < 2 \mbox{ MHz AM is usable but not specified. AM specifications apply with ALC on, and envelope peaks } \\ \hline \end{tabular}$

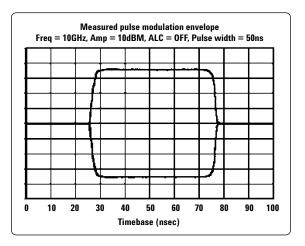
< maximum specified power.
3. For AM depth settings > 90% or > 20 dB, deep AM mode or 1 kHz ALC BW is recommended.

Nide band AM	Rate (typical 1 dB bandwidth)	
	ALC on	1 kHz to 80 MHz
	ALC off	DC to 80 MHz
	External I input	
	Sensitivity	0.5 V = 100%
	Input impedance	50 Ω (nominal)
xternal modulation inputs	Modulation types	AM, FM, and ΦM
Ext1 & Ext2)	Input impedance	50 or 600 Ω (nominal), switched
	High/low indicator	A P
	(100 Hz to 10 MHz BW, ac coupled inputs only)	Activated when input level error exceeds 3% (nomina
imultaneous modulation	•	AM, FM, and ΦM can sum simultaneous inputs rinternal2) Any given source (Ext1, Ext2, internal1,
nternal modulation source	Dual function generators provides two indepen	adapt signals (internal1 and internal2) for use with
nternal modulation source	Dual function generators provides two indeper AM, FM, Φ M, or LF Out. Waveforms	ndent signals (internal1 and internal2) for use with Sine, square, positive ramp, negative ramp, triangle, Gaussian poise, uniform poise, swept sine, dual sine
iternal modulation source	AM, FM, ΦM, or LF Out. Waveforms	Sine, square, positive ramp, negative ramp, triangle,
nternal modulation source	AM, FM, ΦM, or LF Out. Waveforms Rate range	Sine, square, positive ramp, negative ramp, triangle, Gaussian noise, uniform noise, swept sine, dual sine
iternal modulation source	AM, FM, ΦM, or LF Out. Waveforms Rate range Sine	Sine, square, positive ramp, negative ramp, triangle, Gaussian noise, uniform noise, swept sine, dual sine 0.5 Hz to 1 MHz
iternal modulation source	AM, FM, ΦM, or LF Out. Waveforms Rate range Sine Square, ramp, triangle	Sine, square, positive ramp, negative ramp, triangle, Gaussian noise, uniform noise, swept sine, dual sine 0.5 Hz to 1 MHz 0.5 Hz to 100 kHz
ternal modulation source	AM, FM, ΦM, or LF Out. Waveforms Rate range Sine Square, ramp, triangle Resolution	Sine, square, positive ramp, negative ramp, triangle, Gaussian noise, uniform noise, swept sine, dual sine 0.5 Hz to 1 MHz 0.5 Hz to 100 kHz 0.5 Hz
ternal modulation source	AM, FM, ΦM, or LF Out. Waveforms Rate range Sine Square, ramp, triangle Resolution Accuracy	Sine, square, positive ramp, negative ramp, triangle, Gaussian noise, uniform noise, swept sine, dual sine 0.5 Hz to 1 MHz 0.5 Hz to 100 kHz
nternal modulation source	AM, FM, ΦM, or LF Out. Waveforms Rate range Sine Square, ramp, triangle Resolution	Sine, square, positive ramp, negative ramp, triangle, Gaussian noise, uniform noise, swept sine, dual sine 0.5 Hz to 1 MHz 0.5 Hz to 100 kHz 0.5 Hz Same as timebase Internal1 or internal2. Also provides monitoring of
nternal modulation source	AM, FM, ΦM, or LF Out. Waveforms Rate range Sine Square, ramp, triangle Resolution Accuracy LF out Output	Sine, square, positive ramp, negative ramp, triangle, Gaussian noise, uniform noise, swept sine, dual sine 0.5 Hz to 1 MHz 0.5 Hz to 100 kHz 0.5 Hz Same as timebase Internal1 or internal2. Also provides monitoring of internal1 or internal2 when used for AM, FM, or ΦM
iternal modulation source	AM, FM, ΦM, or LF Out. Waveforms Rate range Sine Square, ramp, triangle Resolution Accuracy LF out Output	Sine, square, positive ramp, negative ramp, triangle, Gaussian noise, uniform noise, swept sine, dual sine 0.5 Hz to 1 MHz 0.5 Hz to 100 kHz 0.5 Hz Same as timebase Internal1 or internal2. Also provides monitoring of
nternal modulation source	AM, FM, ΦM, or LF Out. Waveforms Rate range Sine Square, ramp, triangle Resolution Accuracy LF out Output	Sine, square, positive ramp, negative ramp, triangle, Gaussian noise, uniform noise, swept sine, dual sine 0.5 Hz to 1 MHz 0.5 Hz to 100 kHz 0.5 Hz Same as timebase Internal1 or internal2. Also provides monitoring of internal1 or internal2 when used for AM, FM, or ΦM 0 to 3 V _{peak} , into 50 Ω (nominal)
nternal modulation source	AM, FM, ΦM, or LF Out. Waveforms Rate range Sine Square, ramp, triangle Resolution Accuracy LF out Output Amplitude Output impedance	Sine, square, positive ramp, negative ramp, triangle, Gaussian noise, uniform noise, swept sine, dual sine 0.5 Hz to 1 MHz 0.5 Hz to 100 kHz 0.5 Hz Same as timebase Internal1 or internal2. Also provides monitoring of internal1 or internal2 when used for AM, FM, or ΦM 0 to 3 V _{peak} , into 50 Ω (nominal)
nternal modulation source	AM, FM, ΦM, or LF Out. Waveforms Rate range Sine Square, ramp, triangle Resolution Accuracy LF out Output Amplitude Output impedance Swept sine mode:	Sine, square, positive ramp, negative ramp, triangle, Gaussian noise, uniform noise, swept sine, dual sine 0.5 Hz to 1 MHz 0.5 Hz to 100 kHz 0.5 Hz Same as timebase Internal1 or internal2. Also provides monitoring of internal1 or internal2 when used for AM, FM, or ΦM 0 to 3 V _{peak} , into 50 Ω (nominal) 50 Ω (nominal)
nternal modulation source	AM, FM, ΦM, or LF Out. Waveforms Rate range Sine Square, ramp, triangle Resolution Accuracy LF out Output Amplitude Output impedance Swept sine mode: (frequency, phase continuous)	Sine, square, positive ramp, negative ramp, triangle, Gaussian noise, uniform noise, swept sine, dual sine 0.5 Hz to 1 MHz 0.5 Hz to 100 kHz 0.5 Hz Same as timebase Internal1 or internal2. Also provides monitoring of internal1 or internal2 when used for AM, FM, or ΦM 0 to 3 V _{peak} , into 50 Ω (nominal)
nternal modulation source	AM, FM, ΦM, or LF Out. Waveforms Rate range Sine Square, ramp, triangle Resolution Accuracy LF out Output Amplitude Output impedance Swept sine mode: (frequency, phase continuous) Operating modes	Sine, square, positive ramp, negative ramp, triangle, Gaussian noise, uniform noise, swept sine, dual sine 0.5 Hz to 1 MHz 0.5 Hz to 100 kHz 0.5 Hz Same as timebase Internal1 or internal2. Also provides monitoring of internal1 or internal2 when used for AM, FM, or ΦM 0 to 3 V _{peak} . into 50 Ω (nominal) 50 Ω (nominal)

1. Internal2 is not available when using swept sine or dual sine modes.

Pulse modulation¹

	Standard	Option 1E6	
	≥ 500 MHz to ≤3.2 GHz	\geq 10 MHz to \leq 3.2 GHz	> 3.2 GHz
On/off ratio	80 dB (typical)	80 dB	80 dB
Rise/fall times (Tr, Tf)	100 ns (typical)	10 ns (8 ns typical)	10 ns (6 ns typical)
Pulse width			
Internally leveled	≥ 2 µs (typical)	≥ 1µs	≥ 1µs
Level hold (ALC Off	≥ 0.5 µs (typical)	≥ 20 ns (typical)	≥ 20 ns (typical)
with power search) ²			
Repetition frequency			
Internally leveled	10 Hz to 250 kHz	10 Hz to 500 kHz	10 Hz to 500 kHz
	(typical)	(typical)	(typical)
Level hold (ALC Off	dc to 1 MHz (typical)	dc to 10 MHz (typical)	dc to 10 MHz with
power search) ²			(typical)
Level accuracy (relative	e to CW)		
Internally leveled	±0.5 dB	± 0.5 dB	± 0.5 dB
			±0.15 (typical)
Level hold (ALC Off with	±0.5 dB (typical)	± 1.0 dB (typical)	≤ 20 GHz ±0.8 dB
power search) ²			(typical)
Width compression	±50 ns (typical)	±5 ns (typical)	±5 ns (typical)
Video feed-through ³	< 200 mV (typical)	< 125 mV (typical)	< 2 mV (typical)
Video delay			
(Ext input to Video)	40 ns (nominal)	40 ns (nominal)	40 ns (nominal)
RF delay (Tm)			
(Video to RF output)	280 ns (nominal)	45 ns (nominal)	35 ns (nominal)
Pulse overshoot (Vor)	< 10% (typical)	< 1 GHz 20% (typical)	< 10% (typical)
		≥ 1 GHz 10% (typical)	
Input level	+1 V _{peak} = RF On	+1 V _{peak} = RF On	+1 V _{peak} = RF On
Input impedance	50 Ω , (nominal)	50 Ω , (nominal)	50 Ω , (nominal)



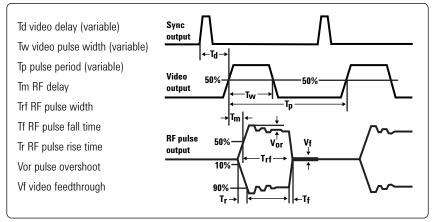
3.

^{1.} With ALC off, specs apply after the execution of power search. Specs apply with Atten Hold off (default mode), or ALC level between 0 and +10 dBm.

^{2.} Power search is a calibration routine that improves level accuracy in ALC-off mode. Un-pulsed RF power will be present typically up to 50 ms when executing power search. With attenuator in 0 dB position. Video feed-through decreases with attenuator setting.

Internal pulse generator

Modes	Free-run, triggered, triggered with delay, doublet,
	and gated. Triggered with delay, doublet, and gated
	require external trigger source.
Period (PRI) (Tp)	70 ns to 42 s
	(Repetition frequency: 0.024 Hz to 14.28 MHz)
Pulse width (Tw)	10 ns to 42 s
Delay (Td)	
Free-run mode	0 to ±42 s
Triggered with delay and doublet modes	75 ns to 42 s with ± 10 ns jitter
Resolution	10 ns (width, delay, and PRI)



Vector modulation

5

Conversion loss (dB)

-5

-15

5.

ersion loss (dB) Λ

-5

ا 8-10

-15

External I/Q inputs Input impedance switched 50 or 600 W (nominal) Input range¹ Minimum 0.1 V_{rms}, maximum 1V_{peak} \pm 1 dB within \pm 40 MHz of carrier (with ALC off) (typical) Flatness Measured I/Q frequency response² 1 5 GHz 3 GHz 5 (qB) 0 Conversion loss (01-0-10 -15 -0.10 0.00 0.15 -0.15 -0.10 -0.15 -0.05 0.05 0.10 -0.05 0.00 0.05 0.10 0.15 Offset from carrier (GHz) Offset from carrier (GHz) 12 GHz 20 GHz 5 ٩, 0 OSS sion -5 ano 0-10 -15 -0.15 -0.10 0.00 0.10 0.15 -0.05 0.05 -0.15 -0.10 -0.05 0.00 0.05 0.10 0.15 Offset from carrier (GHz) Offset from carrier (GHz) Formats: BPSK, QPSK, 16-256QAM Vector accuracy³ $(\alpha = 0.3, \text{Root Nyquist filter, symbol rate 4 Msyms/s})$ EVM <1.2% RMS, < 0.8% RMS (typical) Origin offset 250 kHz to 3.2 GHz -45 dBc (typical) 3.2 to 20 GHz -50 dBc (typical) I/Q adjustments I & Q offsets External inputs (600 Ω) ± 5 Volts External inputs (50 Ω) ± 50 % Internal baseband generator \pm 50 % I/Q attenuation 0 to 40 dB I/Q gain balance $\pm 4 \text{ dB}$ I/Q guadrature skew ± 10° range (typical) Low pass filter Selectable 40 MHz or through I/Q baseband outputs Differential I, I bar, Q, Q bar Single ended I, Q Frequency range DC to 40 MHz Output voltage into 50 W 1.5 V_{p-p} (typical) ± 3 V DC offset adjustments DC offset resolution 1 mV Low pass filter Selectable 40 MHz or though

> 1. For optimum signal quality, the I and Q inputs should be 0.7 V_{peak}, with $\sqrt{(l^2 + Q^2)} + 150 \text{ mV}_{rms}$. Different RMS levels are accommodated by adjusting the internal I/Q modulator attenuator, which may be either manually or automatically set. The minimum input level required to maintain RF level accuracy is $\sqrt{(l^2 + 0^2)} = 0.1 \text{ V}_{\text{rms}}$. Sine wave response, measured with input level = 100 mV_{rms} on one channel, and ALC off.

2.

3. Measured with Agilent 89441A Vector Signal Analyzer. Valid after executing I/Q calibration, and instrument is maintained within \pm 5°C of calibration temperature. RF power < 0 dBm. External I/Q input level $\sqrt{(l^2 + Q^2)}$ = 0.3 V_{rms} , I/Q modulator attenuator = 10 dB.

I/Q baseband generator (arbitrary waveform mode) (Option 002)

Channels	2 [I and Q]
Resolution	16 bits [1/65,536]
Baseband waveform memory	
Length (playback)	32 Msamples/channel
Length (storage)	1.2 Gsamples on 6 GB hard drive (Option 005)
Waveform segments	
Segment length	60 samples to 32 Msamples
Maximum number of segments	4,096
Minimum memory allocation	256 samples or 1 kbyte blocks
Waveform sequences	
Maximum total number of segments	16,384
Sequencing	Continuously repeating
Maximum number of sequences	16,384
Maximum segments/sequence	1 to 32,768
Maximum segment repetitions	1 to 65,536
Clock	
Sample rate	1 Hz to 100 MHz
Resolution	0.001 Hz
Accuracy	Same as timebase +2 ⁴² [in non-integer applications]
Reconstruction filter: [fixed]	50 MHz [used for all symbol rates]
Baseband spectral purity	
[full scale sinewave]	
Harmonic distortion	100 kHz to 2 MHz: < -65 dBc (typical)
Phase noise	<-127 dBc/Hz (typical)
	(baseband output of 10 MHz sinewave at 20 kHz offset)
IM performance	<-74 dB (typical)
	(two sinewaves at 950 kHz and 1050 kHz at baseband)
Triggers	
Туреѕ	Continuous, single, gated, segment advance
Source	Trigger key, external, remote [LAN, GPIB, RS-232]
External polarity	Negative, positive
External delay time	10 ns to 40 sec plus latency
External delay resolution	10 ns

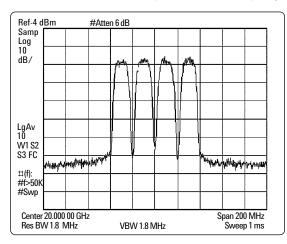
Markers

(Markers are defined in a segment during the waveform generation process, or from the PSG front panel. A marker can also be tied to the RF blanking feature of the PSG.)

Marker polarity	Negative, positive
Number of markers	4
Multi-carrier	
Number of carriers	Up to 100 (limited by a max bandwidth of 80 MHz depending on symbol rate and modulation type)
Frequency offset (per carrier)	-40 MHz to +40 MHz
Power offset (per carrier)	0 dB to –40 dB
Modulation	
PSK	BPSK, QPSK, OQPSK, π/4DQPSK, 8PSK,16PSK, D8PSK
QAM	4, 16, 32, 64, 256
FSK	Selectable: 2, 4, 8, 16
MSK	
Data	Random ONLY

Measured multi-carrier

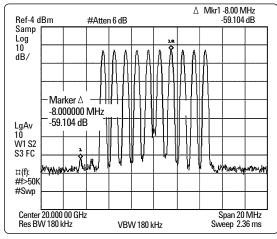
4 Carriers with 64 QAM at 10 Msymbls\s with 20 MHz spacing



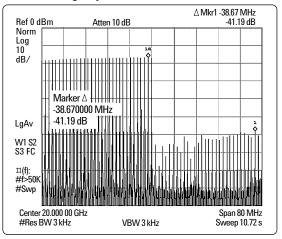
Multitone

Number of tones Frequency spacing Phase (per tone) Power offset (per tone) 2 to 64, with selectable on/off state per tone 100 Hz to 80 MHz Fixed or random 0 to -40 dB

Measured multitone



Measured image rejection > 3.2 GHz



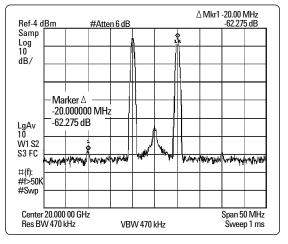
Two-tone

Frequency spacing IM distortion 250 kHz to 3.2 GHz >3.2 GHz to 20 GHz 100 Hz to 80 MHz (symmetrical about carrier)

<-45 dBc for RF levels < 0dBm (typical)

<-55 dBc for RF levels < 0dBm (typical)

Measured two-tone



I/Q baseband generator
(real-time mode)
(Option 002)

Design modulation tumos (quatam format)	
Basic modulation types (custom format) PSK	
	BPSK, QPSK, OQPSK, $\pi/4DQPSK$, 8PSK, 16PSK, D8PSK
MSK	User-defined phase offset from 0 to 100°
QAM	4, 16, 32, 64, 256
FSK	Selectable: 2, 4, 8, 16 level symmetric
User defined	Custom map of up to 16 deviation levels
Symbol rate	Maximum deviation
< 5 MHz	4 times symbol rate
5 MHz to 50 MHz	20 MHz
Resolution: 0.1 Hz	
1/0	Custom map of 256 unique values
FIR filter	
Selectable	Nyquist, root Nyquist, Gaussian, rectangular
	lpha: 0 to 1, B _b T: 0.1 to 1
Custom FIR	16-bit resolution, up to 64 symbols long, automatically
	resampled to 1024 coefficients (max)
	> 32 to 64 symbol filter: symbol rate <12.5 MHz
	> 16 to 32 symbol filter: symbol rate \leq 25 MHz
	Internal filters switch to 16 tap when symbol rate is
	between 25 and 50 MHz
Symbol rate	
For external serial data:	Adjustable from 1000 symbols/sec to a maximum symbol
	rate of 50 Mbits/sec + #bits/symbol
For internally generated data:	Adjustable from 1000 symbols/sec to 50 Msymbols/sec.
, 3	and a maximum of 8 bits per symbol. Modulation quality
	may be degraded at high symbol rates.
Baseband reference frequency	Data clock can be phase locked to an external reference.
Input	ECL, CMOS, TTL compatible, 50 Ω AC coupled
Frame trigger delay control	and the second
Range	0 to 1,048,575 bits
Resolution	1 bit
·····	

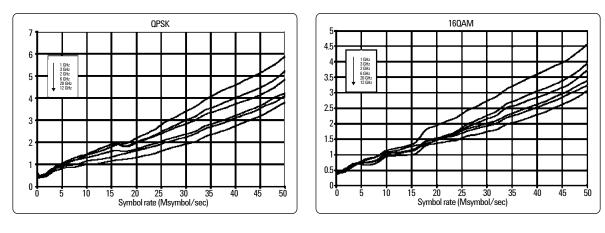
Data types Internally generated data Pseudo-random patterns PN9, PN11, PN15, PN20, PN23 Repeating sequence Any 4-bit sequence Other fixed patterns Direct-pattern RAM [PRAM] Max size 32 Mbits (each bit uses an entire sample space) Use Non-standard framing **User file** Max size 3.2 Mbytes Continuous modulation or internally generated Use TDMA standard **Externally generated data** Serial data Туре Inputs Data, bit clock, symbol sync Accepts data rates $\pm 5\%$ of specified data rate

Internal burst shape control

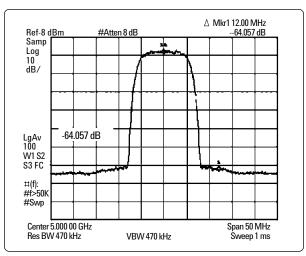
Varies with standards and bit rates Rise/fall time range Rise/fall delay range Up to 30 bits

0 to 63.5 bits

Measured EVM



Measured spectral re-growth 5 GHz carrier with 16 QAM signal at 10 Msymbls/s



Wideband external I/Q inputs

(Option 015)

RF output frequency range:	3.2 to 20 GHz	
Input		
Input (baseband) frequency range	DC to > 500 MHz (nominal)	
Input impedance	50 Ω (nominal)	
Recommended input level	0 dBm (nominal)	
Maximum input voltage	±1 volt DC	
I/Q offset adjustments	±50%	
RF path filters ¹		
Carrier Frequency	Low-pass 3 dB cutoff frequency (nominal)	
>3.2 to 5 GHz	5.5 GHz	

8.9 GHz

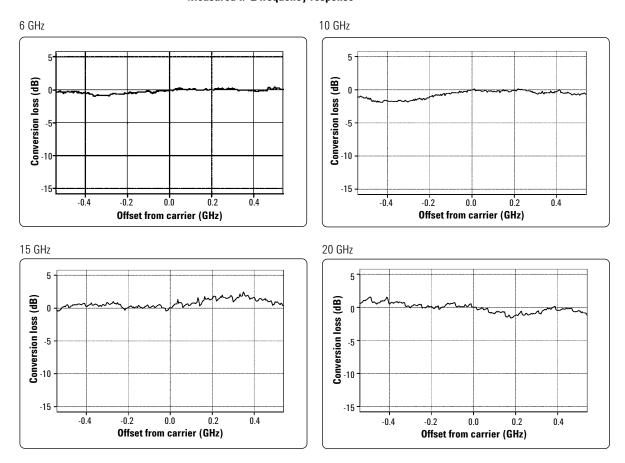
13.9 GHz

22.5 GHz

> 12.8 GHz Measured I/Q frequency response

>5 to 8 GHz

> 8 to 12.8 GHz



Remote programming

General

Front panel connectors

(All connectors are BNC female unless otherwise noted.)³

Interfaces	GPIB (IEEE-488.2,1987) with listen and talk, RS-232,
Interfaces	and 10BaseT LAN interface.
Control languages	SCPI version 1997.0. Also will emulate most applicable
	Agilent 836xxB, Agilent 837xxB, and Agilent 8340/41B
	commands, providing general compatibility with ATE
	systems which include these signal generators.
IEEE-488 functions	SH1, AH1, T6, TE0, L4, LE0, SR1, RL1, PP0, DC1, DT0, C0, E2.
ISO compliant	This family of signal generators is manufactured in an
	ISO-9001 registered facility in concurrence with
	Agilent Technologies commitment to quality.
	Agrent recimologies communent to quality.
Power requirements	90 to 267 Vac 50 to 60 Hz, (automatically selected),
·	650 W maximum.
	Option UNS: External module allows operation at 400Hz
Operating temperature range	0 to 55°C ¹
Storage temperature range ²	-40 to 71°C
gp	With Option 005: -4° to 65°C, gradient less than
	20°C/hour
Shock and vibration	Meets MIL-STD-28800E Type III, Class 3.
EMC	Conducted and radiated interference and immunity meets
	IEC/EN 61326-1 and MIL-STD-461C Part 2, RE02. Meets
	radiated emission requirements of CISPR Pub 11/1997
	Group 1 class A.
Storage registers	Memory is shared by instrument states, user data files,
Storage registers	sweep list files, and waveform sequences. Depending on
	the number and size of these files, up to 800 storage
	registers and 10 register sequences are available.
Security	Display blanking.
Compatibility	Agilent Technologies 83550 Series millimeter heads (not
Compatibility	for use with I/Q modulation), Agilent Technologies 8757D
	scalar network analyzers, Agilent Technologies EPM
<u> </u>	Series power Meters.
Self-test	Internal diagnostic routine tests most modules (including
	microcircuits) in a preset condition. For each module, if its
	node voltages are within acceptable limits, then the
	module "passes" the test.
Weight	< 25 kg (54 lb.) net, < 33 kg (74 lb.) shipping.
Dimensions	178 mm H x 426 mm W x 498 mm D
	(7" H x 16.8" W x 19.6" D in.).
Recommended calibration cycle	24 months
RF output	Nominal output impedance 50 Ω . Precision APC-3.5

RF output	Nominal output impedance 50 Ω . Precision APC-3.5
	male, or Type-N with Option 1ED.
ALC input	Used for negative external detector leveling.
	Nominal input impedance 120 k $m \Omega$, damage level ±15 V.
LF output	Outputs the internally generated LF source. Nominal
	output impedance 50 Ω .
External input 1	Drives either AM, FM, or Φ M. Nominal input impedance
	50 or 600 ${f \Omega}$, damage levels are 5 V _{rms} and 10 V _{peak} .
External input 2	Drives either AM, FM, or Φ M. Nominal input impedance
	50 or 600 $\Omega,$ damage levels are 5 V_{rms} and 10 $V_{peak}.$

^{1.} Save and recall of user files and instrument states from Option 005 Hard Drive is guaranteed only over the range 0 to 40°C.

^{2.} Storage below -20°C Instrument states may be lost.

^{3.} Digital inputs and output are 3.3 V CMOS unless indicated otherwise. Inputs will accept 5 V CMOS, 3V CMOS, or TTL voltage levels.

Pulse/trigger gate input	Accepts input signal for external fast pulse modulation. Also accepts external trigger pulse input for internal pulse modulation. Nominal impedance 50 Ω . Damage levels are 5 V _{rms} and 10 V _{peak} .
Pulse video out	Outputs a signal that follows the RF output in all pulse modes. TTL-level compatible, nominal source impedance 50 Ω .
Pulse sync out	Outputs a synchronizing pulse, nominally 50 ns width, during internal and triggered pulse modulation. TTL-level compatible, nominal source impedance 50 Ω.
Data clock input	Accepts a data clock signal to synchronize serial data for use with internal baseband generator (Option 002). Maximum rate 50 MHz. Damage levels are > + 5.5 and <-0.5 V.
Data input	Accepts serial data for use with internal baseband generator (Option 002). Maximum rate 50 Mb/s. Data must be valid on the falling edges of data clock (normal mode) or the symbol sync (symbol mode). Damage levels are > + 5.5 and <-0.5 V.
l input	Accepts an "I" input either for I/Q modulation or for wideband AM. Nominal input impedance 50 or 600 Ω . Damage levels are 1 V _{rms} and 5 V _{peak} .
Q input	Accepts a "Q" input for 1/0 modulation. Nominal input impedance 50 or 600 Ω . Damage levels are 1 V _{rms} and 5 V _{peak} .
Symbol sync input	Accepts symbol sync signal for use with internal baseband generator (Option 002). Symbol sync might occur once per symbol or be a single, one bit wide pulse to synchronize the first bit of the first symbol. Maximum rate 50 MHz. Damage levels are >+5.5 and <-0.5 V.
Auxillary interface (Dual mode)	Used for RS-232 serial communication and for Master/Slave source synchronization. (9-pin D-subminiature female connector) For Master/Slave operation use Agilent Technologies part #8120-8806 Master/Slave interface cable.
GPIB	Allows communication with compatible devices.
LAN 10 MHz input	Allows 10baseT LAN communication Accepts an external reference (timebase) input (at 1, 2,
	2.5, 5, 10 MHz for standard and 10 MHz only for Option UNR) Nominal input impedance 50 Ω .
10 MHz output	UNR) Nominal input impedance 50 Ω. Damage levels > +10 dBm Outputs internal or external reference signal. Nominal
10 MHz output Sweep output (Dual mode)	UNR) Nominal input impedance 50 Ω . Damage levels > +10 dBm
	UNR) Nominal input impedance 50 Ω. Damage levels > +10 dBm Outputs internal or external reference signal. Nominal output impedance 50 Ω. Nominal output power +4 dBm Supplies a voltage proportional to the RF power or frequency sweep ranging form 0 volts at the start of sweep to +10 volts (nominal) at the end of sweep,

Rear panel connectors (All connectors are BNC female unless otherwise noted.)¹

^{1.} Digital inputs and output are 3.3 V CMOS unless indicated otherwise. Inputs will accept 5 V CMOS, 3V CMOS, or TTL voltage levels.

Stop sweep In/Out	Open-collector, TTL-compatible input/output. In ramp
	sweep operation, provides low level (nominally 0 V) during
	sweep retrace and bandcross intervals, and high level
	during the forward portion of the sweep. Sweep will stop
	when grounded externally, sweep will resume when
	allowed to go high.
Trigger output (Dual mode)	Outputs a TTL signal. High at start of dwell, or when waiting
	for point trigger; low when dwell is over or point trigger is
	received, In ramp sweep mode, provides 1601 equally-spaced
	1us pulses (nominal) across a ramp sweep. When using
	LF out, provides 2 us pulse at start of LF sweep.
Trigger input	Accepts TTL signal for triggering point-to-point in manual
	sweep mode, or to trigger start of LF sweep. Damage lev-
els	\geq +10 V or \leq -4 V.
Source module interface	Provides bias, flatness correction, and leveling
	connections to the Agilent model 83550 Series mm-wave
	source modules.
Source settled	Provides an output trigger that indicates when the signal
	generator has settled to a new frequency or power level.
	High indicates source not settled, Low indicates source
	settled.
Z-axis Blank/Markers	During ramp sweep, supplies + 5 V (nominal) level during
	retrace and bandswitch intervals. Supplies – 5 V (nominal)
	level when the RF frequency is at a marker frequency.
EFC	> 0.25 ppm for –5 to +5 V Input impedance: >1 M Ω
.25 – 3.2 GHz coherent carrier output	Outputs RF signal modulated with FM or Φ M but not I/Q,
	AM or pulse. Nominal power 0 dBm. Frequency range
	from 250 MHz to 3.2 GHz. Not useful for output frequency
	> 3.2 GHz. Damage levels 20 Vdc and 13 dBm reverse
	RF power. (SMA female)
Baseband generator reference input	Accepts 0 to + 20 dBm sinewave, or TTL squarewave,
gp	reference input to use as reference clock for the baseband
	generator (Option 002). Phase locks the internal data
	generator to the external reference: the RF frequency is
	still locked to the 10 MHz reference. Rate is 250 kHz to
	100 MHz 50 Ω (nominal), AC coupled.
Burst gate input	Accepts signal for gating burst power for use with internal
	baseband generator (Option 002). The burst gating is
	used when you are externally supplying data and clock
	information. The input signal must be synchronized with
	the external data input that will be output during the
	burst. The burst power envelope and modulated data are
	internally delayed and re-synchronized. The input signal
	must be CMOS high for normal burst RF power or CW RF
	output power and CMOS low for RF off. Damage levels
	are $>+5.5$ and <-0.5 V.
Event 1 output	In real-time mode, outputs a pattern or frame synchronization
	pulse for triggering or gating external equipment, for use
	with internal baseband generator (Option 002). May be
	set to start at the beginning of a pattern, frame, or timeslot
	and is adjustable to within \pm one timeslot with one bit
	resolution in arbitrary waveform mode outputs a timing
	resolution. In arbitrary waveform mode, outputs a timing signal generated by marker 1.

Event 2 output	In real-time mode, outputs a data enable signal for gating external equipment, for use with internal baseband generator (Option 002). Applicable when external data is clocked into internally generated timeslots. Data is enabled when signal is low. In arbitrary waveform mode, outputs a timing signal generated by marker 2.
I and Q outputs	Outputs the analog I/Q modulation signals from the interna baseband generator. Nominal output impedance 50 Ω , DC-coupled. Damage levels ±3.5 V.
l-bar and Q-bar outputs	Outputs the complement of the I and Q signals for differential applications. Nominal output impedance 50 Ω , DC-coupled. Damage levels ±3.5 V.
Pattern trigger input	Accepts signal to trigger internal pattern or frame generator to start single pattern output, for use with internal baseband generator (Option 002). Minimum pulse width 100 ns. Damage levels are >+5.5 and <-0.5 V.
Wideband I and Q inputs	Direct high-bandwidth analog inputs to I/Q modulator in 3.2 to 20 GHz range. Not calibrated. 0 dBm maximum. (Option 015 only)
Alternate power input	Accepts CMOS signal for synchronization of external data and alternate power signal timing. Damage levels are >+8 and <-4V.
Data clock output	Relays a CMOS bit clock signal for synchronizing serial data
Data output	Outputs data from the internal data generator or the externally supplied signal at data input. CMOS signal.
Event 3 output	In arbitrary waveform mode, outputs a timing signal generated by marker 3. Damage levels >+8 and <4 V.
Event 4 output	In arbitrary waveform mode, outputs a timing signal generated by marker 4. Damage levels >+8 and <4 V.
Symbol sync output	Outputs CMOS symbol clock for symbol synchronization, one data clock period wide.

Auxillary I/O connector (37-pin) used with Option 002

Related Agilent literature

PSG Signal Generator, Brochure Literature number: 5988-7538EN

Agilent E8247/57C PSG CW and Analog Signal Generator, Data Sheet Literature number 5988-7454EN

Agilent E8267C PSG Vector Signal Generator Data Sheet Literature number 5988-6632EN

PSG Self Guided Demo Literature number 5988-2414EN

PSG Configuration Guide Literature number 5988-7541EN

PSG Series Product Note: Millimeter Head Literature number 5988-2567EN

PSG Two-tone and Multi-tone Application Note AN 1410 Literature number: 5988-7689EN



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